

March 2013

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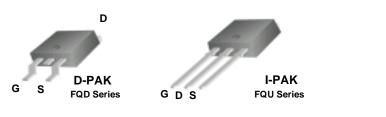
## FQD13N10L / FQU13N10L **N-Channel QFET MOSFET**

**100 V, 10 A, 180 m**Ω

#### **Description**

This N-Channel enhancement mode power MOSFET is **Features** produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

- 10 A, 60 V,  $R_{DS(on)}$  = 180 m $\Omega$  (Max) @ $V_{GS}$  = 10 V,  $I_D = 5.0 A$
- Low Gate Charge (Typ. 8.7 nC)
- · Low Crss (Typ. 20 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating



### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD13N10L / FQU13N10L	Unit
V <sub>DSS</sub>	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		10	Α
	- Continuous (T <sub>C</sub> = 100°C)		6.3	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	40	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		95	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	10	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		4.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
$P_{D}$	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W
	Power Dissipation (T <sub>C</sub> = 25°C)		40	W
	- Derate above 25°C		0.32	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.13	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W	

<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	S	Min	Тур	Max	Unit
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
ΔBV <sub>DSS</sub> / ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C			0.09		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V				1	μА
		V <sub>DS</sub> = 80 V, T <sub>C</sub> = 125°C				10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1.0		2.0	V
R <sub>DS(on)</sub>	Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 5.0 \text{ A}$ On-Resistance $V_{GS} = 5 \text{ V}, I_D = 5.0 \text{ A}$				0.142	0.18	Ω
20(011)					0.158	0.2	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 5.0 \text{ A}$	(Note 4)		8.7		S
Dynam	ic Characteristics						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			400	520	pF
C <sub>oss</sub>	Output Capacitance				95	125	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				20	25	pF
Switchi	ng Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_{D} = 12.8 \text{ A},$ $R_{G} = 25 \Omega$			7.5	25	ns
t <sub>r</sub>	Turn-On Rise Time				220	450	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				22	55	ns
t <sub>f</sub>	Turn-Off Fall Time	-	(Note 4, 5)		72	150	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = 80 V, I <sub>D</sub> = 12.8 A,			8.7	12	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS} = 60 \text{ V}, I_D = 12.6 \text{ A},$ $V_{GS} = 5 \text{ V}$ (Note 4, 5)			2.0		nC
Q <sub>gd</sub>	Gate-Drain Charge				5.3		nC
	-						1
Drain-S	ource Diode Characteristics a	nd Maximum Rating	s				
I <sub>S</sub>	Maximum Continuous Drain-Source Did	ode Forward Current				10	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F	Forward Current				40	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V, } I_{S} = 10 \text{ A}$				1.5	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 12.8 \text{ A},$			75		ns
^		dl / dt 100 \ /	(Note 4)				_

 $dI_F / dt = 100 A/\mu s$ 

(Note 4)

0.17

## $Q_{rr}$

- Notes: Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature 2. L = 1.43mH, I\_{AS} = 10A, V\_{DD} = 25V, R\_{G} = 25  $\Omega$ , Starting T\_J = 25°C 3. I\_{SD}  $\leq$  12.8A, di/rd  $\leq$  300A/µs, V\_{DD}  $\leq$  8V<sub>DS</sub>, Starting T\_J = 25°C 4. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

Reverse Recovery Charge

μС

## **Typical Characteristics**

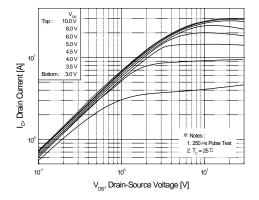


Figure 1. On-Region Characteristics

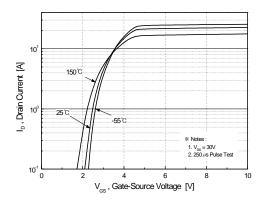


Figure 2. Transfer Characteristics

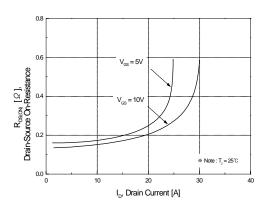


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

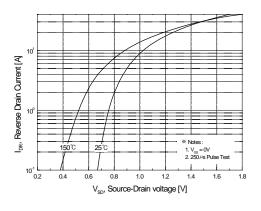


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

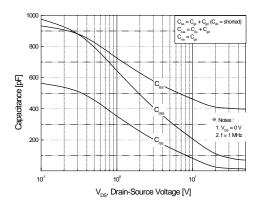


Figure 5. Capacitance Characteristics

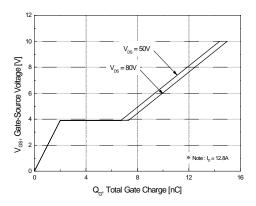


Figure 6. Gate Charge Characteristics

# BV <sub>DSS</sub> , (Normalized) Drain-Source Breakdown Voltage 1. V<sub>GS</sub> = 0 V 2. I<sub>D</sub> = 250 //A -100

-50

Typical Characteristics (Continued)

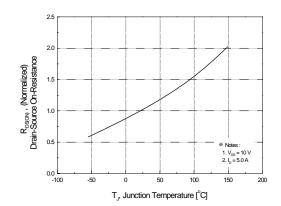
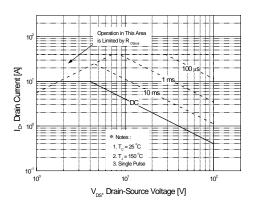


Figure 7. Breakdown Voltage Variation vs. Temperature

 $T_J$ , Junction Temperature [°C]

150

Figure 8. On-Resistance Variation vs. Temperature



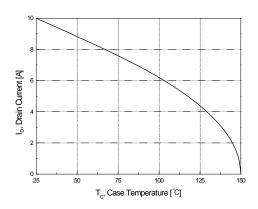


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

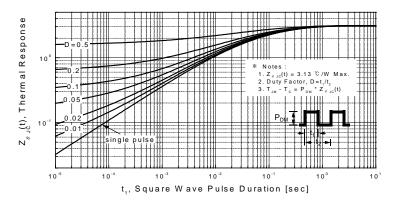
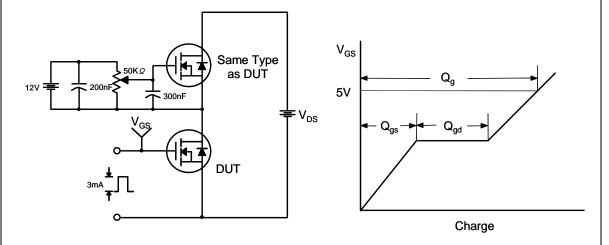
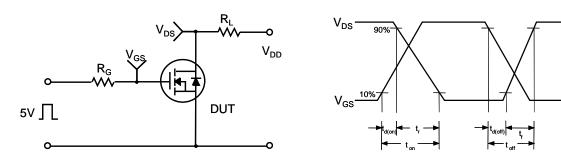


Figure 11. Transient Thermal Response Curve

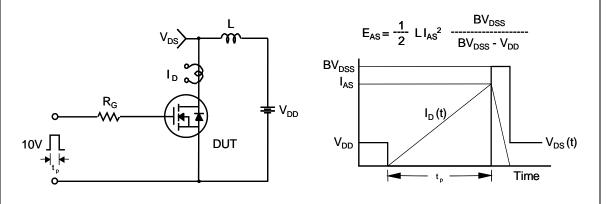
#### **Gate Charge Test Circuit & Waveform**



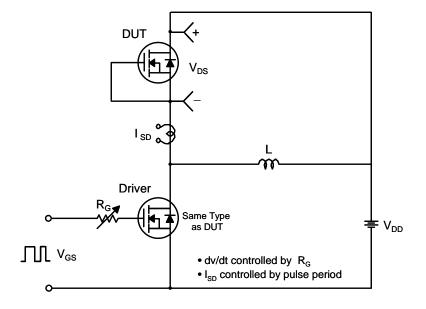
#### **Resistive Switching Test Circuit & Waveforms**

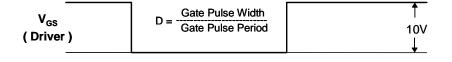


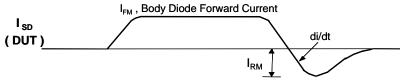
#### **Unclamped Inductive Switching Test Circuit & Waveforms**



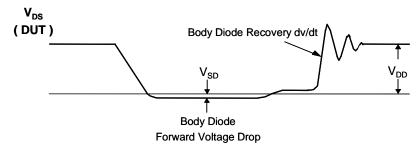
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







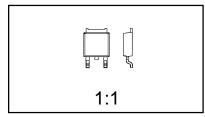
Body Diode Reverse Current



#### **Package Dimensions**

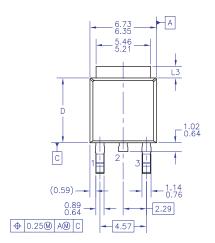
## TO-252 (DPAK) (FS PKG Code 36)

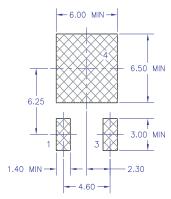




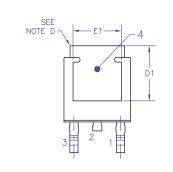
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

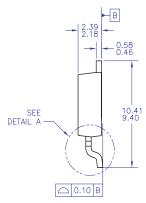
Part Weight per unit (gram): 0.33

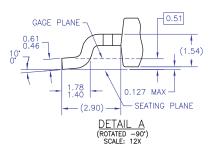




LAND PATTERN RECOMMENDATION







NOTES: UNLESS OTHERWISE SPECIFIED

- UNLESS OTHERWISE SPECIFIED
  ALL DIMENSIONS ARE IN MILLIMETERS.
  THIS PACKAGE CONFORMS TO JEDEC, TO-252,
  ISSUE C, VARIATION AA & AB, DATED NOV. 1999.
  DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-1994.
  HEAT SINK TOP EDGE COULD BE IN CHAMFERED
  CORNERS OR EDGE PROTRUSION.

- DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN

# Package Dimensions (Continued) **IPAK** 6.60 ±0.20 $2.30 \pm 0.20$ $5.34 \pm 0.20$ $0.50 \pm 0.10$ (0.50)(4.34)(0.50)0.60 ±0.20 0.70 ±0.20 $6.10 \pm 0.20$ 0.80 ±0.10 $1.80 \pm 0.20$ 9.30 ±0.30 MAX0.96 $0.76 \pm 0.10$ $0.50 \pm 0.10$ 2.30TYP 2.30TYP [2.30±0.20] [2.30±0.20]





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- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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